

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	$-R_{\theta JA}$	50	62.5	°C/W				
Maximum Junction-to-Ambient ^A	Steady-State	Γ _θ JA	73	110	°C/W				
Maximum Junction-to-Lead ^C	Steady-State	$R_{ ext{ heta}JL}$	31	40	°C/W				

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC I	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA, V _{GS} =0V	I _D =-250μA, V _{GS} =0V				V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-24V, V _{GS} =0V				-1	μA
			TJ=55°C			-5	
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±25V				±1	μA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$		-1	-2.8	-3	V
I _{D(ON)}	On state drain current	V _{GS} =-10V, V _{DS} =-5V		-40			А
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-20V, I _D =-8A			14.1	18	mΩ
			T _J =125°C		20	25	
		V _{GS} =-10V, I _D =-8A	V _{GS} =-10V, I _D =-8A		17.1	21	mΩ
		V _{GS} =-4.5V, I _D =-4A		44		mΩ	
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-8A			15		S
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-1	V	
I _S	Maximum Body-Diode Continuous Current					-2.6	Α
DYNAMI	C PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =-15V, f=1MHz			1760	2200	pF
C _{oss}	Output Capacitance				360		pF
C _{rss}	Reverse Transfer Capacitance				255		pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			6.4	8	Ω
SWITCH	ING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-8A			30	38	nC
Q _{gs}	Gate Source Charge				7		nC
Q_{gd}	Gate Drain Charge				8		nC
t _{D(on)}	Turn-On DelayTime				12.5		ns
t _r	Turn-On Rise Time	V _{GS} =-10V, V _{DS} =-15V, R _L =1.8Ω, R _{GEN} =3Ω			10.5		ns
t _{D(off)}	Turn-Off DelayTime				40		ns
t _f	Turn-Off Fall Time				23		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-8A, dI/dt=100A/μs			24	30	ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =-8A, dI/dt=100A/μ		16		nC	

A: The value of R_{eJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}$ C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

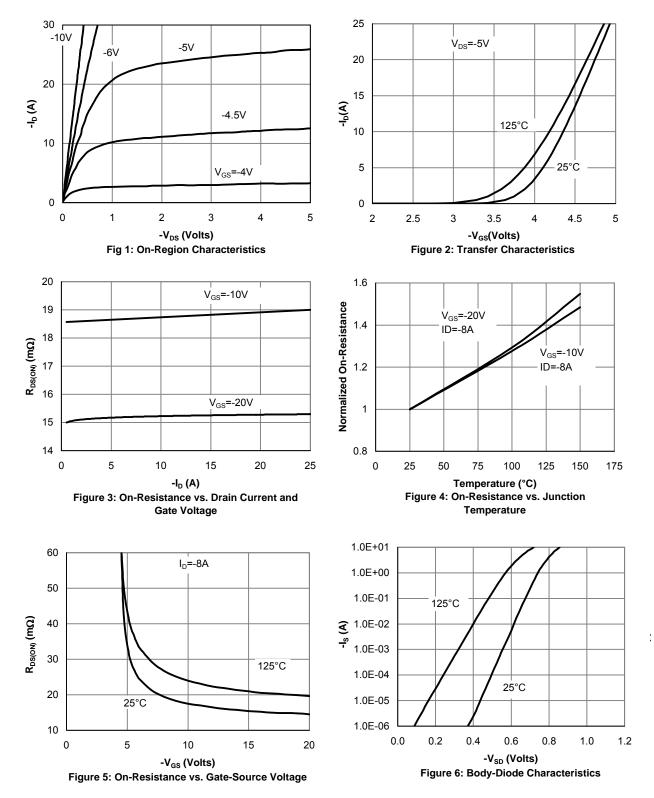
C. The R $_{\rm \theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm \theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using $80\mu s$ pulses, duty cycle 0.5% max.

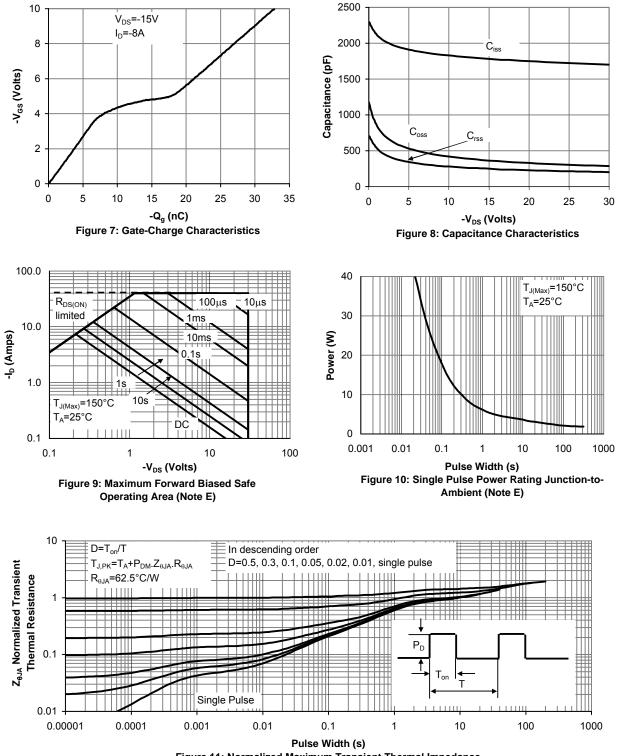
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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Figure 11: Normalized Maximum Transient Thermal Impedance

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